

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination KIMIZUKA ET AL.	
			Examiner RACHEL KAHN	Art Unit 1796	Page 1 of 1

U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A US-6,017,390	01-2000	Charych et al.	117/68
*	B US-6,576,679	06-2003	Kimizuka et al.	516/102
*	C US-6,210,537	04-2001	Murphy et al.	204/157.15
D	US-			
E	US-			
F	US-			
G	US-			
H	US-			
I	US-			
J	US-			
K	US-			
L	US-			
M	US-			

FOREIGN PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
N	JP 94041532 B2	06-1994	Japan	ASAOKUMA S et al.	
O					
P					
Q					
R					
S					
T					

NON-PATENT DOCUMENTS

*	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
U	Cheung et al, Molecular Organization and Electrical Properties of Mixed Langmuir-Blodgett Multilayer Thin Films of Polypyrrole, 1990, Conjugated Polymeric Materials, Bredas and Chance (eds), p91-99.
V	Kimizuka et al, AFM Observation of Organogel Nanostructures on Graphite in the Gel-Assisted Transfer Technique, Chemistry Letters, 1998, p 967-68.
W	
X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.